

# Laser-Induced Damage Threshold (LIDT) Measurement Report

## ISO21254-2: S-on-1 Test Procedure

Sample: 20LDR15KG

**Request from:**

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Tester/date:

M. Sciuka / 2015-11-10

**Specimen**

Name of sample:

20LDR15KG

Type of specimen:

UVFS

S1: (Tp avg. > 98%, Tp min >96%, Rs > 99.9%) @  
1010-1050, AOI = 55.4 ± 1.5 deg

S2: Uncoated

Storage, cleaning:

Wrapped in paper for optics, plastic bag

**Test specification**

First harmonic of pulsed “Pharos” laser ( $\lambda=1030$  nm, linear polarization, pulse duration 11.1 ps.),  $\lambda/2$  plate combined with additional polarizer attenuator, online scattered light based damage detection, offline inspection of damage morphology with Nomarski microscopy.

**Laser parameters used for testing**

Wavelength: 1030 nm  
Angle of incidence: 55.4 deg.  
Pulse spectral width (WFHM): 28 nm  
Polarization state: linear P and S  
Pulse repetition frequency: 10 kHz  
Spatial beam profile in target plane: TEM<sub>00</sub>  
Longitudinal beam profile: Gaussian: Kerr lens mode locked  
Beam diameter in target plane ( $1/e^2$ ): 49.5 ± 0.1 μm (average from 64 pulses)  
Pulse duration: 11.1 ps

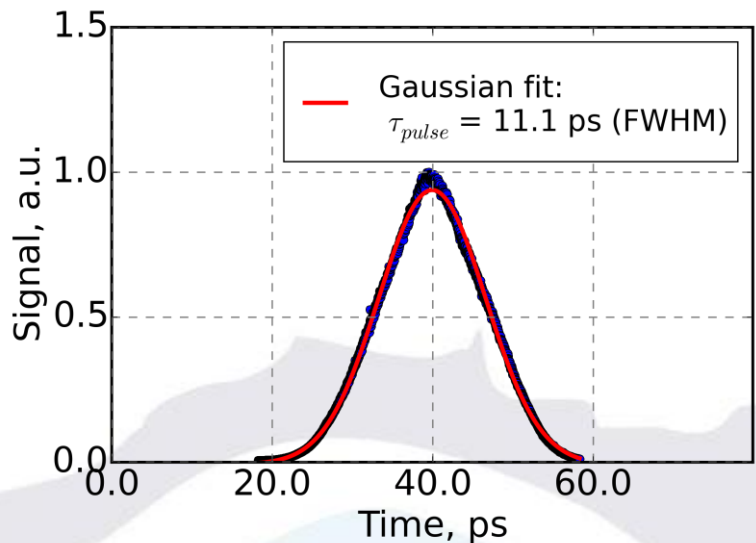
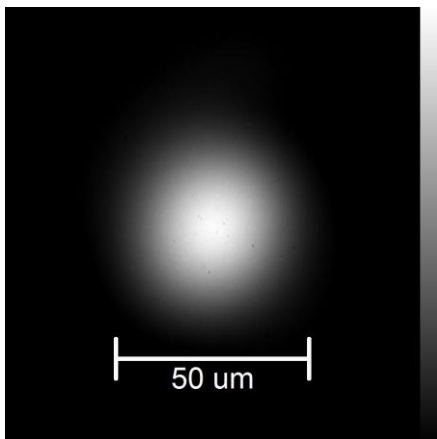


Fig. 1. Spatial beam profile in target plane (left) and pulse autocorrelation curve (right)

**Test procedure:**

Number of irradiated sites:  
Arrangement of test sites:  
Minimum distance between sites:  
Damage detection:  
Test environment:  
Storage of the specimen:  
Cleaning:  
Definition of LIDT:

**S-on-1 test**

403 (P pol.), 490 (S pol.)  
Hexagon close packing: equally spaced  
300 μm  
Scattered light diode/Nomarski microscopy  
Industrial environment  
Original packaging, normal laboratory conditions  
Compressed air  
LIDT is defined as a middle fluence point between highest zero and lowest nonzero damage probability points. (See Fig. 2 for details)

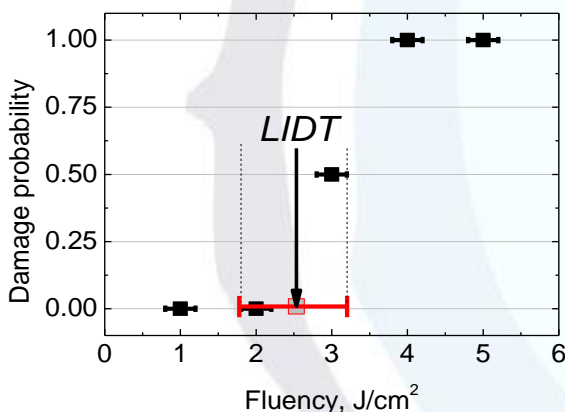


Fig. 2. Definition of LIDT estimated in case of deterministic (ps) damage probability data.

**Test result:**

Table1. LIDT Results of sample 20LDR15KG

Test mode	Threshold, J/cm <sup>2</sup>	
	P polarization	S polarization
1-on-1	4.75 ± 0.08	10.30 ± 0.18
10000-on-1	4.28 ± 0.11	8.34 ± 0.16

Measured at LIDARIS 2015-11-10  
www.lidaris.com

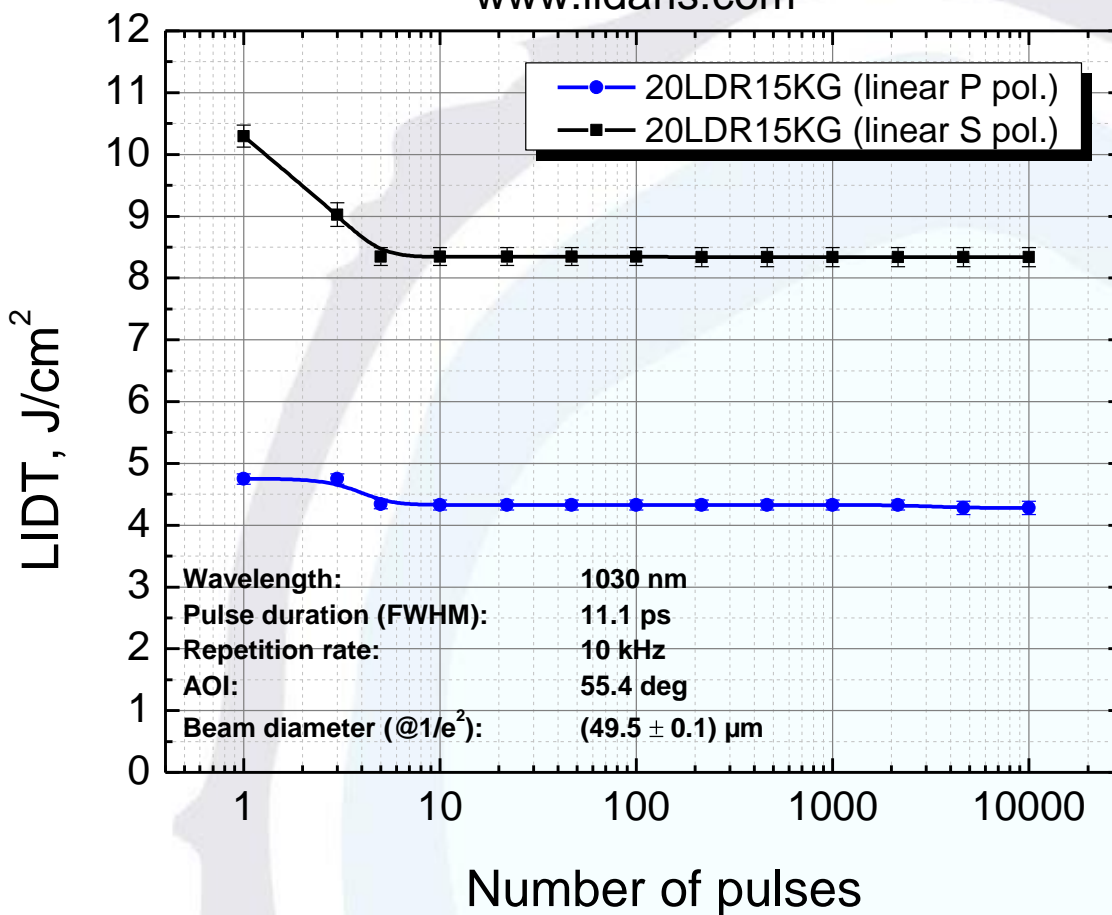


Fig. 3. Characteristic damage curve.

**Typical damage morphology:**

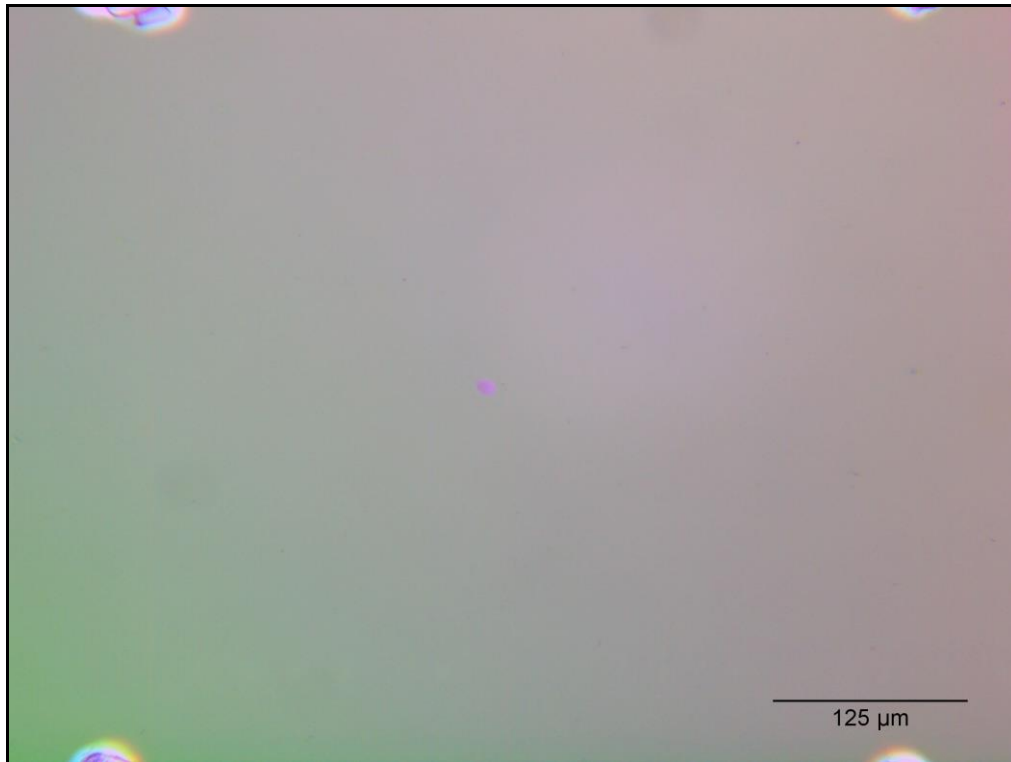


Fig. 4. Typical front surface damage morphology for P polarization  
(Fluence  $5.17 \text{ J/cm}^2$ , damage after 1 pulse)

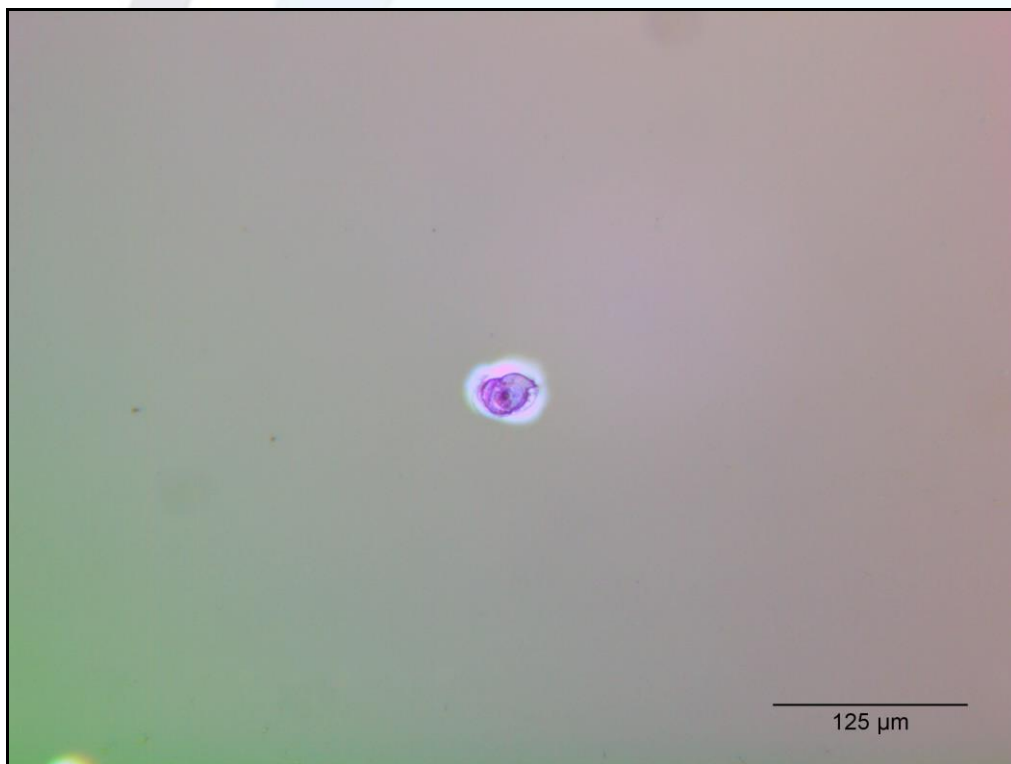


Fig. 5. Typical front surface damage morphology for P polarization  
(Fluence  $4.32 \text{ J/cm}^2$ , damage after 4262 pulses)

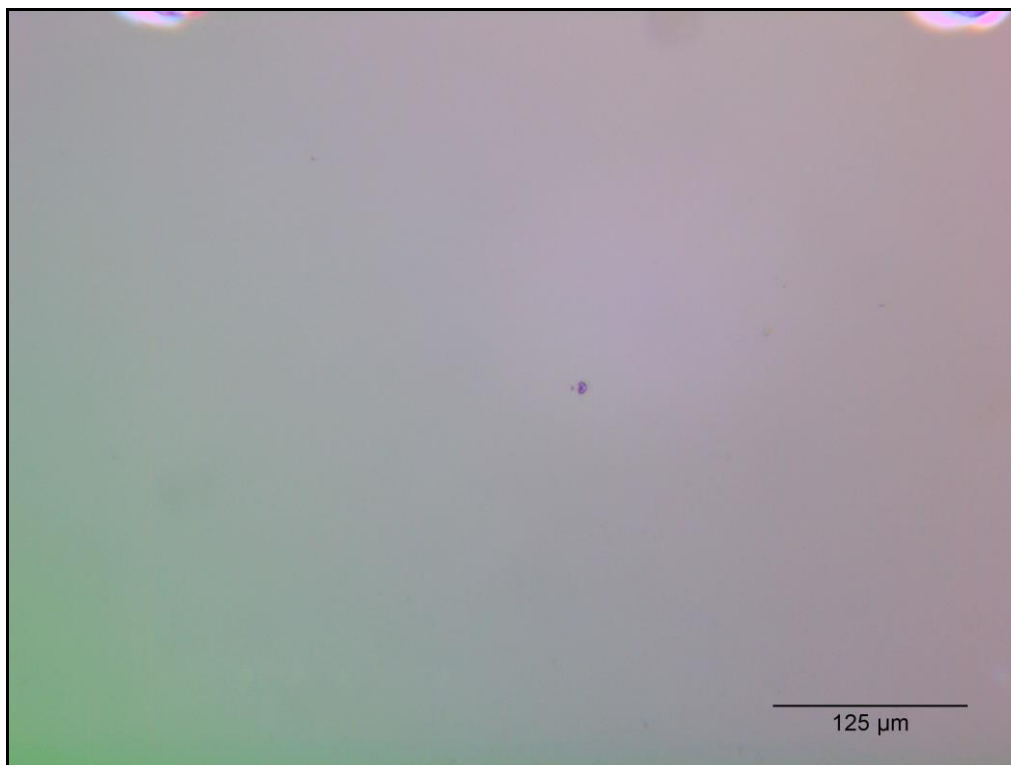


Fig. 6. Typical front surface damage morphology for S polarization  
(Fluence  $12.62 \text{ J/cm}^2$ , damage after 1 pulse)

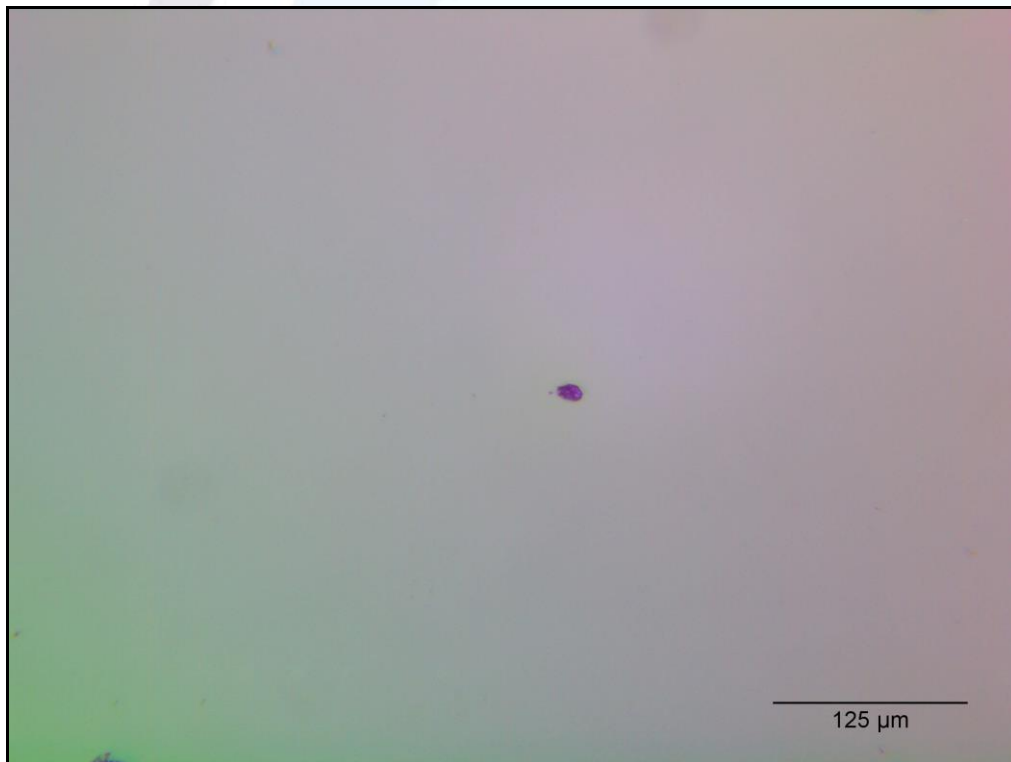


Fig. 7. Typical front surface damage morphology for S polarization  
(Fluence  $8.36 \text{ J/cm}^2$ , damage after 5 pulses)

**Technical note:**

According to the ISO 21254-2 norm for spatial beam profiling perpendicular to the direction of beam propagation and angles of incidence differing from 0 degrees, the cosine of the angle of incidence has to be included in the calculation of the effective area. Therefore the beam diameter increase due to the angle of incidence (AOI) is taken into account when calculating the laser fluency.

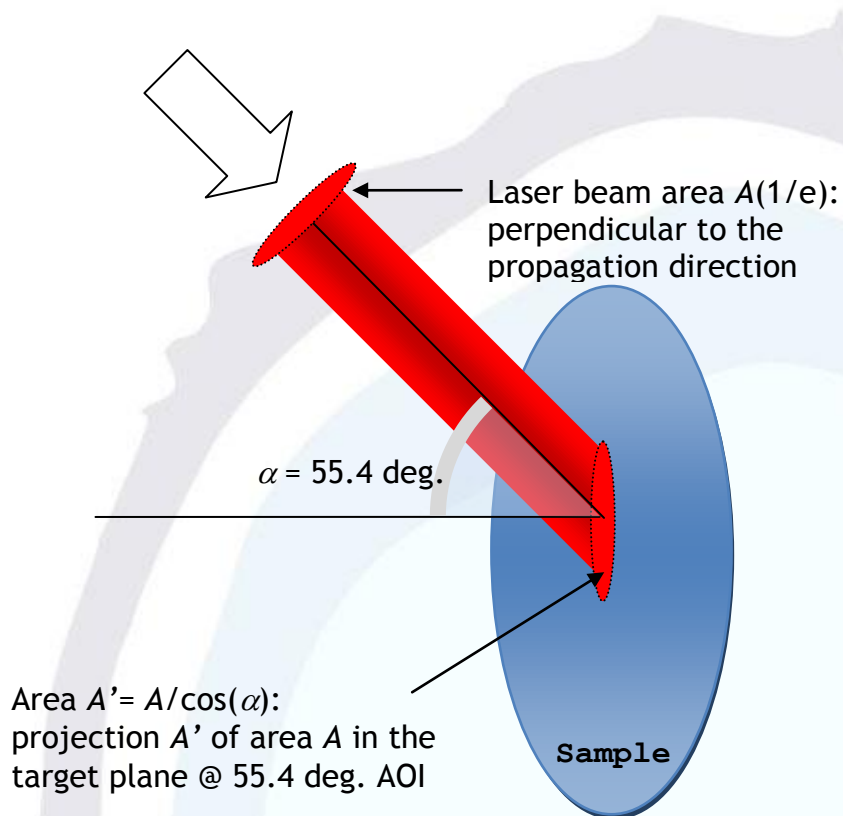


Fig. 8. Oblique incidence.